

Features

- Optimized for 1.8V systems
 - As fast as 5.7 ns pin-to-pin delays
 - As low as 13 μ A quiescent current
- Industry's best 0.18 micron CMOS CPLD
 - Optimized architecture for effective logic synthesis. Refer to the CoolRunner™-II family data sheet for architecture description.
 - Multi-voltage I/O operation — 1.5V to 3.3V
- Available in multiple package options
 - 100-pin VQFP with 80 user I/O
 - 144-pin TQFP with 118 user I/O
 - 132-ball CP (0.5mm) BGA with 106 user I/O
 - 208-pin PQFP with 173 user I/O
 - 256-ball FT (1.0mm) BGA with 184 user I/O
 - Pb-free available for all packages
- Advanced system features
 - Fastest in system programming
 - 1.8V ISP using IEEE 1532 (JTAG) interface
 - IEEE1149.1 JTAG Boundary Scan Test
 - Optional Schmitt-trigger input (per pin)
 - Unsurpassed low power management
 - DataGATE enable (DGE) signal control
 - Two separate I/O banks
 - RealDigital 100% CMOS product term generation
 - Flexible clocking modes
 - Optional DualEDGE triggered registers
 - Clock divider (divide by 2,4,6,8,10,12,14,16)
 - CoolCLOCK
 - Global signal options with macrocell control
 - Multiple global clocks with phase selection per macrocell
 - Multiple global output enables
 - Global set/reset
 - Advanced design security
 - PLA architecture
 - Superior pinout retention
 - 100% product term routability across function block
 - Open-drain output option for Wired-OR and LED drive
 - Optional bus-hold, 3-state or weak pull-up on selected I/O pins
 - Optional configurable grounds on unused I/Os
 - Mixed I/O voltages compatible with 1.5V, 1.8V, 2.5V, and 3.3V logic levels
 - SSTL2-1, SSTL3-1, and HSTL-1 I/O compatibility
 - Hot pluggable

Description

The CoolRunner™-II 256-macrocell device is designed for both high performance and low power applications. This lends power savings to high-end communication equipment and high speed to battery operated devices. Due to the low power stand-by and dynamic operation, overall system reliability is improved

This device consists of sixteen Function Blocks inter-connected by a low power Advanced Interconnect Matrix (AIM). The AIM feeds 40 true and complement inputs to each Function Block. The Function Blocks consist of a 40 by 56 P-term PLA and 16 macrocells which contain numerous configuration bits that allow for combinational or registered modes of operation.

Additionally, these registers can be globally reset or preset and configured as a D or T flip-flop or as a D latch. There are also multiple clock signals, both global and local product term types, configured on a per macrocell basis. Output pin configurations include slew rate limit, bus hold, pull-up, open drain and programmable grounds. A Schmitt-trigger input is available on a per input pin basis. In addition to storing macrocell output states, the macrocell registers may be configured as "direct input" registers to store signals directly from input pins.

Clocking is available on a global or Function Block basis. Three global clocks are available for all Function Blocks as a synchronous clock source. Macrocell registers can be individually configured to power up to the zero or one state. A global set/reset control line is also available to asynchronously set or reset selected registers during operation. Additional local clock, synchronous clock-enable, asynchronous set/reset and output enable signals can be formed using product terms on a per-macrocell or per-Function Block basis.

A DualEDGE flip-flop feature is also available on a per macrocell basis. This feature allows high performance synchronous operation based on lower frequency clocking to help reduce the total power consumption of the device.

Circuitry has also been included to divide one externally supplied global clock (GCK2) by eight different selections. This yields divide by even and odd clock frequencies.

The use of the clock divide (division by 2) and DualEDGE flip-flop gives the resultant CoolCLOCK feature.

DataGATE is a method to selectively disable inputs of the CPLD that are not of interest during certain points in time.

By mapping a signal to the DataGATE function, lower power can be achieved due to reduction in signal switching.

Another feature that eases voltage translation is I/O banking. Two I/O banks are available on the CoolRunner-II 256 macrocell device that permit easy interfacing to 3.3V, 2.5V, 1.8V, and 1.5V devices.

The CoolRunner-II 256 macrocell CPLD is I/O compatible with various I/O standards (see [Table 1](#)). This device is also 1.5V I/O compatible with the use of Schmitt-trigger inputs.

RealDigital Design Technology

Xilinx CoolRunner-II CPLDs are fabricated on a 0.18 micron process technology which is derived from leading edge FPGA product development. CoolRunner-II CPLDs employ RealDigital, a design technique that makes use of CMOS technology in both the fabrication and design methodology. RealDigital design technology employs a cascade of CMOS gates to implement sum of products instead of traditional sense amplifier methodology. Due to this technology, Xilinx CoolRunner-II CPLDs achieve both high-performance and low power operation.

Supported I/O Standards

The CoolRunner-II 256 macrocell features LVCMOS, LVTTTL, SSTL and HSTL I/O implementations. See [Table 1](#)

for I/O standard voltages. The LVTTTL I/O standard is a general purpose EIA/JEDEC standard for 3.3V applications that use an LVTTTL input buffer and Push-Pull output buffer. The LVCMOS standard is used in 3.3V, 2.5V, 1.8V applications. Both HSTL and SSTL I/O standards make use of a V_{REF} pin for JEDEC compliance. CoolRunner-II CPLDs are also 1.5V I/O compatible with the use of Schmitt-trigger inputs

Table 1: I/O Standards for XC2C256⁽¹⁾

| IOSTANDARD Attribute | Output V_{CCIO} | Input V_{CCIO} | Input V_{REF} | Board Termination Voltage V_{TT} |
|-------------------------|-------------------|------------------|-----------------|------------------------------------|
| LVTTTL | 3.3 | 3.3 | N/A | N/A |
| LVCMOS33 | 3.3 | 3.3 | N/A | N/A |
| LVCMOS25 | 2.5 | 2.5 | N/A | N/A |
| LVCMOS18 | 1.8 | 1.8 | N/A | N/A |
| LVCMOS15 ⁽²⁾ | 1.5 | 1.5 | N/A | N/A |
| HSTL_1 | 1.5 | 1.5 | 0.75 | 0.75 |
| SSTL2_1 | 2.5 | 2.5 | 1.25 | 1.25 |
| SSTL3_1 | 3.3 | 3.3 | 1.5 | 1.5 |

(1) For information on V_{ref} , see [XAPP399](#).

(2) LVCMOS15 requires Schmitt-trigger inputs.

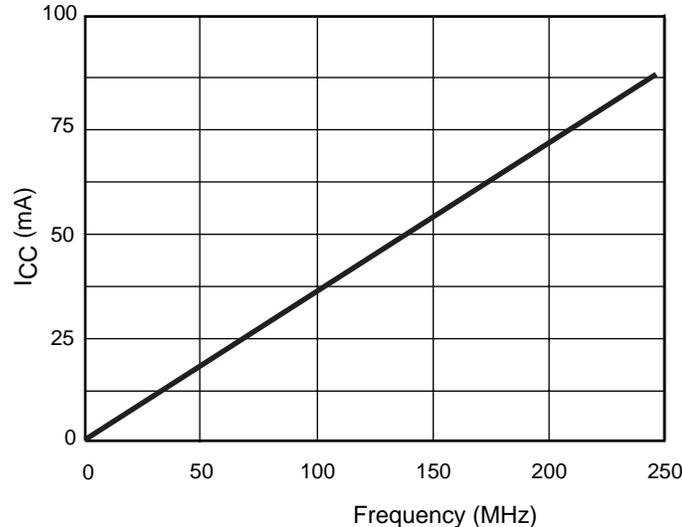


Figure 1: I_{CC} vs Frequency

Table 2: I_{CC} vs Frequency (LVCMOS 1.8V $T_A = 25^\circ\text{C}$)⁽¹⁾

| | Frequency (MHz) | | | | | | | | | | |
|-----------------------|-----------------|-------|-------|-------|-------|-------|-------|-------|-------|-------|-------|
| | 0 | 30 | 50 | 70 | 100 | 120 | 150 | 170 | 190 | 220 | 240 |
| Typical I_{CC} (mA) | 0.021 | 11.68 | 19.40 | 27.01 | 38.18 | 45.54 | 56.32 | 63.37 | 70.40 | 80.90 | 88.03 |

Notes:

- 16-bit up/down, resettable binary counter (one counter per function block).

Absolute Maximum Ratings

| Symbol | Description | Value | Units |
|------------------|-----------------------------------|-------------|-------|
| V_{CC} | Supply voltage relative to ground | -0.5 to 2.0 | V |
| V_{CCIO} | Supply voltage for output drivers | -0.5 to 4.0 | V |
| $V_{JTAG}^{(2)}$ | JTAG input voltage limits | -0.5 to 4.0 | V |
| V_{CCAUX} | JTAG input supply voltage | -0.5 to 4.0 | V |
| $V_{IN}^{(1)}$ | Input voltage relative to ground | -0.5 to 4.0 | V |
| $V_{TS}^{(1)}$ | Voltage applied to 3-state output | -0.5 to 4.0 | V |
| $T_{STG}^{(3)}$ | Storage Temperature (ambient) | -65 to +150 | °C |
| T_J | Junction Temperature | +150 | °C |

Notes:

- Maximum DC undershoot below GND must be limited to either 0.5V or 10 mA, whichever is easiest to achieve. During transitions, the device pins may undershoot to -2.0V or overshoot to +4.5V, provided this over or undershoot lasts less than 10 ns and with the forcing current being limited to 200 mA.
- Valid over commercial temperature range.
- For soldering guidelines and thermal considerations, see the [Device Packaging](#) information on the Xilinx website. For Pb free packages, see [XAPP427](#).

Recommended Operating Conditions

| Symbol | Parameter | | Min | Max | Units |
|-------------|---|---|-----|-----|-------|
| V_{CC} | Supply voltage for internal logic and input buffers | Commercial $T_A = 0^\circ\text{C}$ to $+70^\circ\text{C}$ | 1.7 | 1.9 | V |
| | | Industrial $T_A = -40^\circ\text{C}$ to $+85^\circ\text{C}$ | 1.7 | 1.9 | V |
| V_{CCIO} | Supply voltage for output drivers @ 3.3V operation | | 3.0 | 3.6 | V |
| | Supply voltage for output drivers @ 2.5V operation | | 2.3 | 2.7 | V |
| | Supply voltage for output drivers @ 1.8V operation | | 1.7 | 1.9 | V |
| | Supply voltage for output drivers @ 1.5V operation | | 1.4 | 1.6 | V |
| V_{CCAUX} | JTAG programming | | 1.7 | 3.6 | V |

DC Electrical Characteristics (Over Recommended Operating Conditions)

| Symbol | Parameter | Test Conditions | Typical | Max. | Units |
|----------------|--------------------------------|---|---------|------|---------------|
| I_{CCSB} | Standby current Commercial | $V_{CC} = 1.9\text{V}$, $V_{CCIO} = 3.6\text{V}$ | 33 | 150 | μA |
| I_{CCSB} | Standby current Industrial | $V_{CC} = 1.9\text{V}$, $V_{CCIO} = 3.6\text{V}$ | 54 | 300 | μA |
| I_{CC} | Dynamic current | $f = 1\text{ MHz}$ | - | 410 | μA |
| | | $f = 50\text{ MHz}$ | - | 27 | mA |
| C_{JTAG} | JTAG input capacitance | $f = 1\text{ MHz}$ | - | 10 | pF |
| C_{CLK} | Global clock input capacitance | $f = 1\text{ MHz}$ | - | 12 | pF |
| C_{IO} | I/O capacitance | $f = 1\text{ MHz}$ | - | 10 | pF |
| $I_{IL}^{(2)}$ | Input leakage current | $V_{IN} = 0\text{V}$ or V_{CCIO} to 3.9V | - | +/-1 | μA |
| $I_{IH}^{(2)}$ | I/O High-Z leakage | $V_{IN} = 0\text{V}$ or V_{CCIO} to 3.9V | - | +/-1 | μA |

Notes:

- 16-bit up/down, resettable binary counter (one counter per function block) tested at $V_{CC} = V_{CCIO} = 1.9\text{V}$
- See Quality and Reliability section of the CoolRunner-II family data sheet

LVC MOS 3.3V and LV TTL 3.3V DC Voltage Specifications

| Symbol | Parameter | Test Conditions | Min. | Max. | Units |
|------------|---------------------------|--|--------------------------|------|-------|
| V_{CCIO} | Input source voltage | - | 3.0 | 3.6 | V |
| V_{IH} | High level input voltage | - | 2 | 3.9 | V |
| V_{IL} | Low level input voltage | - | -0.3 | 0.8 | V |
| V_{OH} | High level output voltage | $I_{OH} = -8 \text{ mA}, V_{CCIO} = 3\text{V}$ | $V_{CCIO} - 0.4\text{V}$ | - | V |
| | | $I_{OH} = -0.1 \text{ mA}, V_{CCIO} = 3\text{V}$ | $V_{CCIO} - 0.2\text{V}$ | - | V |
| V_{OL} | Low level output voltage | $I_{OL} = 8 \text{ mA}, V_{CCIO} = 3\text{V}$ | - | 0.4 | V |
| | | $I_{OL} = 0.1 \text{ mA}, V_{CCIO} = 3\text{V}$ | - | 0.2 | V |

LVC MOS 2.5V DC Voltage Specifications

| Symbol | Parameter | Test Conditions | Min. | Max. | Units |
|------------|---------------------------|--|--------------------------|------------------------|-------|
| V_{CCIO} | Input source voltage | - | 2.3 | 2.7 | V |
| V_{IH} | High level input voltage | - | 1.7 | $V_{CCIO} + 0.3^{(1)}$ | V |
| V_{IL} | Low level input voltage | - | -0.3 | 0.7 | V |
| V_{OH} | High level output voltage | $I_{OH} = -8 \text{ mA}, V_{CCIO} = 2.3\text{V}$ | $V_{CCIO} - 0.4\text{V}$ | - | V |
| | | $I_{OH} = -0.1 \text{ mA}, V_{CCIO} = 2.3\text{V}$ | $V_{CCIO} - 0.2\text{V}$ | - | V |
| V_{OL} | Low level output voltage | $I_{OL} = 8 \text{ mA}, V_{CCIO} = 2.3\text{V}$ | - | 0.4 | V |
| | | $I_{OL} = 0.1 \text{ mA}, V_{CCIO} = 2.3\text{V}$ | - | 0.2 | V |

(1) The V_{IH} Max value represents the JEDEC specification for LVC MOS25. The CoolRunner-II input buffer can tolerate up to 3.9V without physical damage.

LVC MOS 1.8V DC Voltage Specifications

| Symbol | Parameter | Test Conditions | Min. | Max. | Units |
|------------|---------------------------|--|------------------------|------------------------|-------|
| V_{CCIO} | Input source voltage | - | 1.7 | 1.9 | V |
| V_{IH} | High level input voltage | - | $0.65 \times V_{CCIO}$ | $V_{CCIO} + 0.3^{(1)}$ | V |
| V_{IL} | Low level input voltage | - | -0.3 | $0.35 \times V_{CCIO}$ | V |
| V_{OH} | High level output voltage | $I_{OH} = -8 \text{ mA}, V_{CCIO} = 1.7\text{V}$ | $V_{CCIO} - 0.45$ | - | V |
| | | $I_{OH} = -0.1 \text{ mA}, V_{CCIO} = 1.7\text{V}$ | $V_{CCIO} - 0.2$ | - | V |
| V_{OL} | Low level output voltage | $I_{OL} = 8 \text{ mA}, V_{CCIO} = 1.7\text{V}$ | - | 0.45 | V |
| | | $I_{OL} = 0.1 \text{ mA}, V_{CCIO} = 1.7\text{V}$ | - | 0.2 | V |

(1) The V_{IH} Max value represents the JEDEC specification for LVC MOS18. The CoolRunner-II input buffer can tolerate up to 3.9V without physical damage.

LVC MOS 1.5V DC Voltage Specifications⁽¹⁾

| Symbol | Parameter | Test Conditions | Min. | Max. | Units |
|------------|------------------------------------|-----------------|-----------------------|-----------------------|-------|
| V_{CCIO} | Input source voltage | - | 1.4 | 1.6 | V |
| V_{T+} | Input hysteresis threshold voltage | - | $0.5 \times V_{CCIO}$ | $0.8 \times V_{CCIO}$ | V |
| V_{T-} | | - | $0.2 \times V_{CCIO}$ | $0.5 \times V_{CCIO}$ | V |

| Symbol | Parameter | Test Conditions | Min. | Max. | Units |
|-----------------|---------------------------|---|--------------------------|------|-------|
| V _{OH} | High level output voltage | I _{OH} = -8 mA, V _{CCIO} = 1.4V | V _{CCIO} - 0.45 | - | V |
| | | I _{OH} = -0.1 mA, V _{CCIO} = 1.4V | V _{CCIO} - 0.2 | - | V |
| V _{OL} | Low level output voltage | I _{OL} = 8 mA, V _{CCIO} = 1.4V | - | 0.4 | V |
| | | I _{OL} = 0.1 mA, V _{CCIO} = 1.4V | - | 0.2 | V |

Notes:

1. Hysteresis used on 1.5V inputs.

Schmitt Trigger Input DC Voltage Specifications

| Symbol | Parameter | Test Conditions | Min. | Max. | Units |
|-------------------|------------------------------------|-----------------|-------------------------|-------------------------|-------|
| V _{CCIO} | Input source voltage | - | 1.4 | 3.9 | V |
| V _{T+} | Input hysteresis threshold voltage | - | 0.5 x V _{CCIO} | 0.8 x V _{CCIO} | V |
| V _{T-} | | - | 0.2 x V _{CCIO} | 0.5 x V _{CCIO} | V |

SSTL2-1 DC Voltage Specifications

| Symbol | Parameter | Test Conditions | Min. | Typ | Max. | Units |
|---------------------------------|---------------------------|---|--------------------------|------|-------------------------|-------|
| V _{CCIO} | Input source voltage | - | 2.3 | 2.5 | 2.7 | V |
| V _{REF} ⁽¹⁾ | Input reference voltage | - | 1.15 | 1.25 | 1.35 | V |
| V _{TT} ⁽²⁾ | Termination voltage | - | V _{REF} - 0.04 | 1.25 | V _{REF} + 0.04 | V |
| V _{IH} | High level input voltage | - | V _{REF} + 0.18 | - | 3.9 | V |
| V _{IL} | Low level input voltage | - | -0.3 | - | V _{REF} - 0.18 | V |
| V _{OH} | High level output voltage | I _{OH} = -8 mA, V _{CCIO} = 2.3V | V _{CCIO} - 0.62 | - | - | V |
| V _{OL} | Low level output voltage | I _{OL} = 8 mA, V _{CCIO} = 2.3V | - | - | 0.54 | V |

Notes:

1. V_{REF} should track the variations in V_{CCIO}, also peak to peak AC noise on V_{REF} may not exceed ± 2% V_{REF}
2. V_{TT} of transmitting device must track V_{REF} of receiving devices

SSTL3-1 DC Voltage Specifications

| Symbol | Parameter | Test Conditions | Min. | Typ | Max. | Units |
|-----------------|---------------------------|---|------------------|-----|------------------|-------|
| V_{CCIO} | Input source voltage | - | 3.0 | 3.3 | 3.6 | V |
| $V_{REF}^{(1)}$ | Input reference voltage | - | 1.3 | 1.5 | 1.7 | V |
| $V_{TT}^{(2)}$ | Termination voltage | - | $V_{REF} - 0.05$ | 1.5 | $V_{REF} + 0.05$ | V |
| V_{IH} | High level input voltage | - | $V_{REF} + 0.2$ | - | $V_{CCIO} + 0.3$ | V |
| V_{IL} | Low level input voltage | - | -0.3 | - | $V_{REF} - 0.2$ | V |
| V_{OH} | High level output voltage | $I_{OH} = -8 \text{ mA}$, $V_{CCIO} = 3\text{V}$ | $V_{CCIO} - 1.1$ | - | - | V |
| V_{OL} | Low level output voltage | $I_{OL} = 8 \text{ mA}$, $V_{CCIO} = 3\text{V}$ | - | - | 0.7 | V |

Notes:

- V_{REF} should track the variations in V_{CCIO} , also peak to peak AC noise on V_{REF} may not exceed $\pm 2\% V_{REF}$
- V_{TT} of transmitting device must track V_{REF} of receiving devices

HSTL1 DC Voltage Specifications

| Symbol | Parameter | Test Conditions | Min. | Typ | Max. | Units |
|-----------------|---------------------------|---|------------------|-----------------------|-----------------|-------|
| V_{CCIO} | Input source voltage | - | 1.4 | 1.5 | 1.6 | V |
| $V_{REF}^{(1)}$ | Input reference voltage | - | 0.68 | 0.75 | 0.90 | V |
| $V_{TT}^{(2)}$ | Termination voltage | - | - | $V_{CCIO} \times 0.5$ | - | V |
| V_{IH} | High level input voltage | - | $V_{REF} + 0.1$ | - | 1.9 | V |
| V_{IL} | Low level input voltage | - | -0.3 | - | $V_{REF} - 0.1$ | V |
| V_{OH} | High level output voltage | $I_{OH} = -8 \text{ mA}$, $V_{CCIO} = 1.7\text{V}$ | $V_{CCIO} - 0.4$ | - | - | V |
| V_{OL} | Low level output voltage | $I_{OL} = 8 \text{ mA}$, $V_{CCIO} = 1.7\text{V}$ | - | - | 0.4 | V |

Notes:

- V_{REF} should track the variations in V_{CCIO} , also peak-to-peak AC noise on V_{REF} may not exceed $\pm 2\% V_{REF}$
- V_{TT} of transmitting device must track V_{REF} of receiving devices

AC Electrical Characteristics Over Recommended Operating Conditions

| Symbol | Parameter | -6 | | -7 | | Units |
|---------------------|---|------|------|------|------|-------|
| | | Min. | Max. | Min. | Max. | |
| T_{PD1} | Propagation delay single p-term | - | 5.7 | - | 6.7 | ns |
| T_{PD2} | Propagation delay OR array | - | 6.0 | - | 7.5 | ns |
| T_{SUD} | Direct input register clock setup time | 2.6 | - | 3.0 | - | ns |
| T_{SU1} | Setup time (single p-term) | 2.4 | - | 2.8 | - | ns |
| T_{SU2} | Setup time (OR array) | 2.7 | - | 3.3 | - | ns |
| T_{HD} | Direct input register hold time | 0 | - | 0 | - | ns |
| T_H | P-term hold time | 0 | - | 0 | - | ns |
| T_{CO} | Clock to output | - | 4.5 | - | 6.0 | ns |
| $F_{TOGGLE}^{(1)}$ | Internal toggle rate | - | 450 | - | 300 | MHz |
| $F_{SYSTEM1}^{(2)}$ | Maximum system frequency | - | 256 | - | 152 | MHz |
| $F_{SYSTEM2}^{(2)}$ | Maximum system frequency | - | 238 | - | 141 | MHz |
| $F_{EXT1}^{(3)}$ | Maximum external frequency | - | 145 | - | 114 | MHz |
| $F_{EXT2}^{(3)}$ | Maximum external frequency | - | 139 | - | 108 | MHz |
| T_{PSUD} | Direct input register p-term clock setup time | 1.3 | - | 1.7 | - | ns |

| Symbol | Parameter | -6 | | -7 | | Units |
|------------------------------------|---|------|------|------|------|-------|
| | | Min. | Max. | Min. | Max. | |
| T _{PSU1} | P-term clock setup time (single p-term) | 1.2 | - | 1.5 | - | ns |
| T _{PSU2} | P-term clock setup time (OR array) | 1.5 | - | 2.0 | - | ns |
| T _{PHD} | Direct input register p-term clock hold time | 1.1 | - | 1.2 | - | ns |
| T _{PH} | P-term clock hold | 1.0 | - | 1.0 | - | ns |
| T _{PCO} | P-term clock to output | - | 6.5 | - | 7.3 | ns |
| T _{OE/TOD} | Global OE to output enable/disable | - | 5.6 | - | 7.0 | ns |
| T _{POE/TPOD} | P-term OE to output enable/disable | - | 7.3 | - | 8.0 | ns |
| T _{MOE/TMOD} | Macrocell driven OE to output enable/disable | - | 7.4 | - | 9.9 | ns |
| T _{PAO} | P-term set/reset to output valid | - | 7.5 | - | 8.1 | ns |
| T _{AO} | Global set/reset to output valid | - | 5.7 | - | 7.6 | ns |
| T _{SUEC} | Register clock enable setup time | 2.8 | - | 3.1 | - | ns |
| T _{HEC} | Register clock enable hold time | 0 | - | 0 | - | ns |
| T _{CW} | Global clock pulse width High or Low | 1.1 | - | 1.6 | - | ns |
| T _{PCW} | P-term pulse width High or Low | 6.0 | - | 7.5 | - | ns |
| T _{APRPW} | Asynchronous preset/reset pulse width (High or Low) | 6.0 | - | 7.5 | - | ns |
| T _{DGSU} | Set-up before DataGATE latch assertion | 0 | - | 0 | - | ns |
| T _{DGH} | Hold to DataGATE latch assertion | 4.0 | - | 6.0 | - | ns |
| T _{DGR} | DataGATE recovery to new data | - | 8.2 | - | 9.0 | ns |
| T _{DGW} | DataGATE low pulse width | 2.5 | - | 3.5 | - | ns |
| T _{CDRSU} | CDRST setup time before falling edge GCLK2 | 1.6 | - | 2.0 | - | ns |
| T _{CDRH} | Hold time CDRST after falling edge GCLK2 | 0 | - | 0 | - | ns |
| T _{CONFIG} ⁽⁴⁾ | Configuration time | - | 150 | - | 150 | μs |

Notes:

1. F_{TOGGLE} is the maximum clock frequency to which a T-Flip Flop can reliably toggle (see the CoolRunner-II family data sheet for more information).
2. F_{SYSTEM1} (1/T_{CYCLE}) is the internal operating frequency for a device fully populated with one 16-bit counter through one p-term per macrocell while F_{SYSTEM2} is through the OR array.
3. F_{EXT1} (1/T_{SU1}+T_{CO}) is the maximum external frequency using one p-term while F_{EXT2} is through the OR array.
4. Typical configuration current during T_{CONFIG} is approximately 7.7 mA.

Internal Timing Parameters

| Symbol | Parameter ⁽²⁾ | -6 | | -7 | | Units |
|---|------------------------------------|------|------|------|------|-------|
| | | Min. | Max. | Min. | Max. | |
| Buffer Delays | | | | | | |
| T _{IN} | Input buffer delay | - | 2.4 | - | 2.6 | ns |
| T _{DIN} | Direct data register input delay | - | 3.1 | - | 3.9 | ns |
| T _{GCK} | Global Clock buffer delay | - | 1.8 | - | 2.7 | ns |
| T _{GSR} | Global set/reset buffer delay | - | 2.0 | - | 3.5 | ns |
| T _{GTS} | Global 3-state buffer delay | - | 2.1 | - | 3.0 | ns |
| T _{OUT} | Output buffer delay | - | 2.3 | - | 2.6 | ns |
| T _{EN} | Output buffer enable/disable delay | - | 3.5 | - | 4.0 | ns |
| P-term Delays | | | | | | |
| T _{CT} | Control term delay | - | 1.1 | - | 1.4 | ns |
| T _{LOGI1} | Single P-term delay adder | - | 0.5 | - | 1.1 | ns |
| T _{LOGI2} | Multiple P-term delay adder | - | 0.3 | - | 0.5 | ns |
| Macrocell Delay | | | | | | |
| T _{PDI} | Input to output valid | - | 0.5 | - | 0.7 | ns |
| T _{SUI} | Setup before clock | 1.3 | - | 1.8 | - | ns |
| T _{HI} | Hold after clock | 0 | - | 0 | - | ns |
| T _{ECSU} | Enable clock setup time | 0.8 | - | 1.8 | - | ns |
| T _{ECHO} | Enable clock hold time | 0 | - | 0 | - | ns |
| T _{COI} | Clock to output valid | - | 0.4 | - | 0.7 | ns |
| T _{AOI} | Set/reset to output valid | - | 1.4 | - | 1.5 | ns |
| T _{CDBL} | Clock doubler delay | - | 0 | - | 0 | ns |
| Feedback Delays | | | | | | |
| T _F | Feedback delay | - | 1.7 | - | 3.0 | ns |
| T _{OEM} | Macrocell to global OE delay | - | 1.7 | - | 2.5 | ns |
| I/O Standard Time Adder Delays 1.5V CMOS | | | | | | |
| T _{HYS15} | Hysteresis input adder | - | 3.0 | - | 4.0 | ns |
| T _{OUT15} | Output adder | - | 0.8 | - | 1.0 | ns |
| T _{SLEW15} | Output slew rate adder | - | 4.0 | - | 5.0 | ns |
| I/O Standard Time Adder Delays 1.8V CMOS | | | | | | |
| T _{HYS18} | Hysteresis input adder | - | 2.0 | - | 3.0 | ns |
| T _{OUT18} | Output adder | - | 0 | - | 0 | ns |
| T _{SLEW} | Output slew rate adder | - | 2.0 | - | 4.0 | ns |

Internal Timing Parameters (Continued)

| Symbol | Parameter ⁽²⁾ | -6 | | -7 | | Units |
|---|--|------|------|------|------|-------|
| | | Min. | Max. | Min. | Max. | |
| I/O Standard Time Adder Delays 2.5V CMOS | | | | | | |
| T _{IN25} | Standard input adder | - | 0.6 | - | 0.7 | ns |
| T _{HYS25} | Hysteresis input adder | - | 1.5 | - | 3.0 | ns |
| T _{OUT25} | Output adder | - | 0.8 | - | 1.0 | ns |
| T _{SLEW25} | Output slew rate adder | - | 3.0 | - | 4.0 | ns |
| I/O Standard Time Adder Delays 3.3V CMOS/TTL | | | | | | |
| T _{IN33} | Standard input adder | - | 0.5 | - | 0.7 | ns |
| T _{HYS33} | Hysteresis input adder | - | 1.2 | - | 3.0 | ns |
| T _{OUT33} | Output adder | - | 1.2 | - | 1.6 | ns |
| T _{SLEW33} | Output slew rate adder | - | 3.0 | - | 4.0 | ns |
| I/O Standard Time Adder Delays HSTL, SSTL | | | | | | |
| SSTL2-1 | Input adder to T _{IN} , T _{DIN} , T _{GCK} , T _{GSR} , T _{GTS} | - | 0.4 | - | 1.0 | ns |
| | Output adder to T _{OUT} | - | -0.5 | - | 0.0 | ns |
| SSTL3-1 | Input adder to T _{IN} , T _{DIN} , T _{GCK} , T _{GSR} , T _{GTS} | - | 0.4 | - | 1.0 | ns |
| | Output adder to T _{OUT} | - | -0.5 | - | 0.0 | ns |
| HSTL-1 | Input adder to T _{IN} , T _{DIN} , T _{GCK} , T _{GSR} , T _{GTS} | - | 0.6 | - | 1.0 | ns |
| | Output adder to T _{OUT} | - | 0 | - | 0 | ns |

Notes:

- 1.5 ns input pin signal rise/fall.

Switching Characteristics

AC Test Circuit

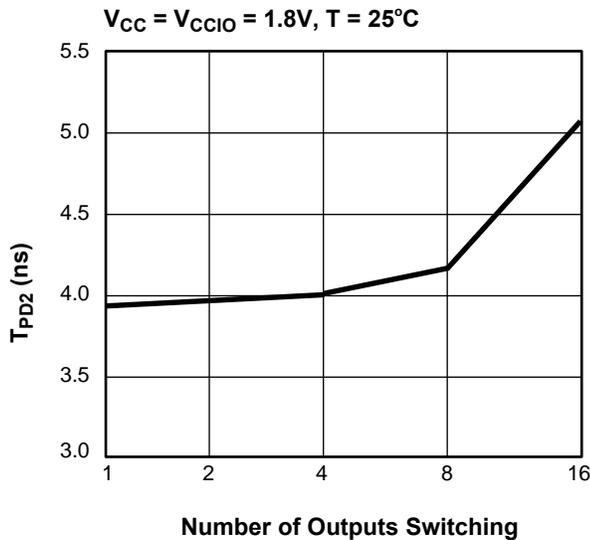
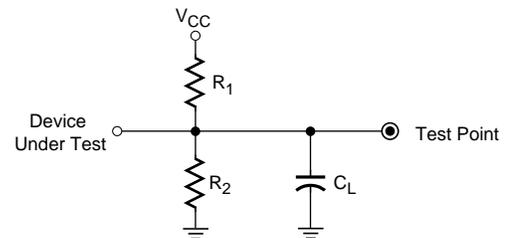


Figure 2: Derating Curve for T_{PD}

DS092_02_092302



| Output Type | R ₁ | R ₂ | C _L |
|-------------|----------------|----------------|----------------|
| LVTTL33 | 268Ω | 235Ω | 35 pF |
| LVC MOS33 | 275Ω | 275Ω | 35 pF |
| LVC MOS25 | 188Ω | 188Ω | 35 pF |
| LVC MOS18 | 112.5Ω | 112.5Ω | 35 pF |
| LVC MOS15 | 150Ω | 150Ω | 35 pF |

C_L includes test fixtures and probe capacitance.
1.5 nsec maximum rise/fall times on inputs.

Figure 3: AC Load Circuit

DS ACT 08 14 02

Typical I/V Output Curves

The I/V curve illustrates the nominal amount of current that an I/O can source/sink at different voltage levels.

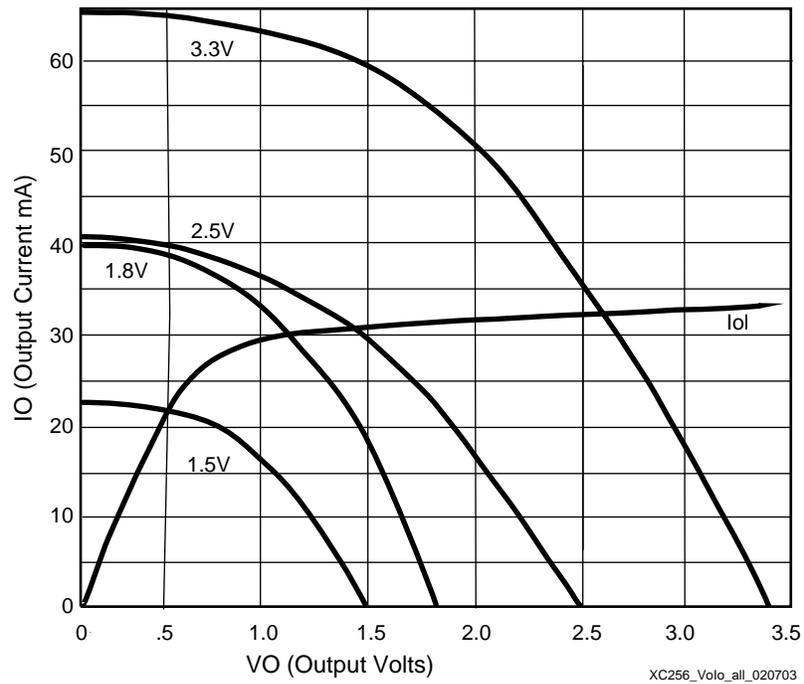


Figure 4: Typical I/V Curve for XC2C256

Pin Descriptions

| Function Block | Macro-cell | VQ100 | CP132 | TQ144 | PQ208 | FT256 | I/O Bank |
|----------------|------------|-------|-------|-------|-------|-------|----------|
| 1 | 1 | - | - | - | 2 | B3 | 2 |
| 1 | 2 | - | - | - | 208 | B4 | 2 |
| 1(GSR) | 3 | 99 | A3 | 143 | 206 | C4 | 2 |
| 1 | 4 | - | - | 142 | 205 | A2 | 2 |
| 1 | 5 | - | - | - | 203 | A3 | 2 |
| 1 | 6 | 97 | B4 | 140 | 202 | A4 | 2 |
| 1 | 7 | - | - | - | - | - | - |
| 1 | 8 | - | - | - | - | - | - |
| 1 | 9 | - | - | - | - | - | - |
| 1 | 10 | - | - | - | - | - | - |
| 1 | 11 | - | - | - | - | - | - |
| 1 | 12 | 96 | - | 139 | 201 | B5 | 2 |
| 1 | 13 | 95 | - | 138 | 200 | A5 | 2 |
| 1 | 14 | 94 | A4 | 137 | 199 | E8 | 2 |
| 1 | 15 | - | - | - | 198 | B6 | 2 |
| 1 | 16 | - | C5 | - | 197 | C7 | 2 |
| 2(GTS2) | 1 | 1 | A1 | 2 | 3 | D3 | 2 |
| 2 | 2 | - | - | - | 4 | C3 | 2 |
| 2(GTS3) | 3 | 2 | B2 | 3 | 5 | E3 | 2 |
| 2 | 4 | - | B1 | 4 | 6 | B2 | 2 |
| 2(GTS0) | 5 | 3 | C3 | 5 | 7 | D4 | 2 |
| 2 | 6 | - | - | - | 8 | D2 | 2 |
| 2 | 7 | - | - | - | - | - | - |
| 2 | 8 | - | - | - | - | - | - |
| 2 | 9 | - | - | - | - | - | - |
| 2 | 10 | - | - | - | - | - | - |
| 2 | 11 | - | - | - | - | - | - |
| 2(GTS1) | 12 | 4 | C2 | 6 | 9 | E5 | 2 |
| 2 | 13 | - | C1 | 7 | 10 | B1 | 2 |
| 2 | 14 | 6 | D2 | 9 | 12 | E4 | 2 |
| 2 | 15 | 7 | - | 10 | 14 | C1 | 2 |
| 2 | 16 | - | D1 | - | - | E2 | 2 |

Pin Descriptions (Continued)

| Function Block | Macro-cell | VQ100 | CP132 | TQ144 | PQ208 | FT256 | I/O Bank |
|----------------|------------|-------|-------|-------|-------|-------|----------|
| 3 | 1 | - | - | 136 | 196 | A6 | 2 |
| 3 | 2 | - | B5 | 135 | 195 | D7 | 2 |
| 3 | 3 | - | - | 134 | 194 | B7 | 2 |
| 3 | 4 | - | A5 | - | 193 | E9 | 2 |
| 3 | 5 | 93 | - | 133 | 192 | A7 | 2 |
| 3 | 6 | - | C6 | - | 191 | D8 | 2 |
| 3 | 7 | - | - | - | - | - | - |
| 3 | 8 | - | - | - | - | - | - |
| 3 | 9 | - | - | - | - | - | - |
| 3 | 10 | - | - | - | - | - | - |
| 3 | 11 | - | - | - | - | - | - |
| 3 | 12 | 92 | - | - | 189 | B8 | 2 |
| 3 | 13 | - | B6 | - | 188 | C8 | 2 |
| 3 | 14 | 91 | A6 | 132 | 187 | A8 | 2 |
| 3 | 15 | - | C7 | - | 186 | E11 | 2 |
| 3 | 16 | 90 | B7 | 131 | 185 | E10 | 2 |
| 4 | 1 | 8 | E3 | 11 | 15 | F2 | 2 |
| 4 | 2 | 9 | - | 12 | 16 | F3 | 2 |
| 4 | 3 | 10 | E2 | 13 | 17 | G4 | 2 |
| 4 | 4 | - | E1 | 14 | 18 | G3 | 2 |
| 4 | 5 | 11 | F3 | 15 | 19 | F5 | 2 |
| 4 | 6 | 12 | F2 | 16 | 20 | G5 | 2 |
| 4 | 7 | - | - | - | - | - | - |
| 4 | 8 | - | - | - | - | - | - |
| 4 | 9 | - | - | - | - | - | - |
| 4 | 10 | - | - | - | - | - | - |
| 4 | 11 | - | - | - | - | - | - |
| 4 | 12 | - | F1 | 17 | 21 | H2 | 2 |
| 4 | 13 | 13 | G1 | - | 22 | H4 | 2 |
| 4 | 14 | - | - | 18 | 23 | H3 | 2 |
| 4 | 15 | - | - | - | - | H1 | 2 |
| 4 | 16 | - | - | - | 25 | H5 | 2 |

Pin Descriptions (Continued)

| Function Block | Macro-cell | VQ100 | CP132 | TQ144 | PQ208 | FT256 | I/O Bank |
|----------------|------------|-------|-------|-------|-------|-------|----------|
| 5 | 1 | - | L3 | - | 49 | R1 | 1 |
| 5 | 2 | - | - | 33 | 48 | N4 | 1 |
| 5 | 3 | - | - | - | 47 | N2 | 1 |
| 5(GCK1) | 4 | 23 | L2 | 32 | 46 | M3 | 1 |
| 5 | 5 | - | L1 | 31 | 45 | P1 | 1 |
| 5(GCK0) | 6 | 22 | K3 | 30 | 44 | M2 | 1 |
| 5 | 7 | - | - | - | - | - | - |
| 5 | 8 | - | - | - | - | - | - |
| 5 | 9 | - | - | - | - | - | - |
| 5 | 10 | - | - | - | - | - | - |
| 5 | 11 | - | - | - | - | - | - |
| 5 | 12 | - | - | - | 43 | L3 | 1 |
| 5 | 13 | - | - | - | 41 | N1 | 1 |
| 5 | 14 | - | - | 28 | 40 | L4 | 1 |
| 5 | 15 | - | - | - | 39 | M1 | 1 |
| 5 | 16 | - | K1 | - | 38 | L5 | 1 |
| 6 | 1 | - | M1 | 34 | 50 | N3 | 1 |
| 6 (CDRST) | 2 | 24 | M2 | 35 | 51 | P2 | 1 |
| 6 | 3 | - | - | - | 54 | P4 | 1 |
| 6(GCK2) | 4 | 27 | N2 | 38 | 55 | P5 | 1 |
| 6 | 5 | - | - | - | 56 | R2 | 1 |
| 6 | 6 | - | - | - | 57 | T1 | 1 |
| 6 | 7 | - | - | - | - | - | - |
| 6 | 8 | - | - | - | - | - | - |
| 6 | 9 | - | - | - | - | - | - |
| 6 | 10 | - | - | - | - | - | - |
| 6 | 11 | - | - | - | - | - | - |
| 6(DGE) | 12 | 28 | P2 | 39 | 58 | T2 | 1 |
| 6 | 13 | - | M3 | 40 | 60 | N5 | 1 |
| 6 | 14 | 29 | N3 | 41 | 61 | R4 | 1 |
| 6 | 15 | - | P3 | 42 | 62 | M5 | 1 |
| 6 | 16 | 30 | M4 | 43 | 63 | R5 | 1 |

Pin Descriptions (Continued)

| Function Block | Macro-cell | VQ100 | CP132 | TQ144 | PQ208 | FT256 | I/O Bank |
|----------------|------------|-------|-------|-------|-------|-------|----------|
| 7 | 1 | - | - | - | 37 | K4 | 1 |
| 7 | 2 | - | - | - | 36 | L2 | 1 |
| 7 | 3 | - | - | - | 35 | K3 | 1 |
| 7 | 4 | - | - | - | 34 | L1 | 1 |
| 7 | 5 | 19 | J2 | 26 | 32 | K5 | 1 |
| 7 | 6 | 18 | J1 | 25 | 31 | K2 | 1 |
| 7 | 7 | - | - | - | - | - | - |
| 7 | 8 | - | - | - | - | - | - |
| 7 | 9 | - | - | - | - | - | - |
| 7 | 10 | - | - | - | - | - | - |
| 7 | 11 | 17 | H3 | 24 | 30 | J4 | 1 |
| 7 | 12 | 16 | H2 | 23 | 29 | K1 | 1 |
| 7 | 13 | 15 | H1 | 22 | 28 | J3 | 1 |
| 7 | 14 | 14 | G3 | 21 | 27 | J2 | 1 |
| 7 | 15 | - | G2 | 20 | - | J5 | 1 |
| 7 | 16 | - | - | 19 | - | J1 | 1 |
| 8 | 1 | - | N4 | 44 | 64 | R6 | 1 |
| 8 | 2 | - | - | 45 | 65 | N6 | 1 |
| 8 | 3 | - | - | 46 | 66 | R3 | 1 |
| 8 | 4 | - | - | - | 67 | M6 | 1 |
| 8 | 5 | - | - | 48 | 69 | T3 | 1 |
| 8 | 6 | 32 | - | 49 | 70 | P6 | 1 |
| 8 | 7 | - | - | - | - | - | - |
| 8 | 8 | - | - | - | - | - | - |
| 8 | 9 | - | - | - | - | - | - |
| 8 | 10 | - | - | - | - | - | - |
| 8 | 11 | 33 | M5 | 50 | 71 | T4 | 1 |
| 8 | 12 | 34 | N5 | 51 | 72 | P7 | 1 |
| 8 | 13 | 35 | P5 | 52 | 73 | T5 | 1 |
| 8 | 14 | 36 | M6 | - | 74 | N7 | 1 |
| 8 | 15 | 37 | N6 | - | 75 | R7 | 1 |
| 8 | 16 | - | - | - | 76 | M7 | 1 |

Pin Descriptions (Continued)

| Function Block | Macro-cell | VQ100 | CP132 | TQ144 | PQ208 | FT256 | I/O Bank |
|----------------|------------|-------|-------|-------|-------|-------|----------|
| 9 | 1 | 78 | C12 | 112 | 160 | B13 | 2 |
| 9 | 2 | 79 | B12 | 113 | 161 | B14 | 2 |
| 9 | 3 | - | - | - | 162 | C13 | 2 |
| 9 | 4 | 80 | A12 | 114 | 163 | A15 | 2 |
| 9 | 5 | | | | 164 | C12 | 2 |
| 9 | 6 | 81 | C11 | 115 | 165 | B12 | 2 |
| 9 | 7 | - | - | - | - | - | - |
| 9 | 8 | - | - | - | - | - | - |
| 9 | 9 | - | - | - | - | - | - |
| 9 | 10 | - | - | - | - | - | - |
| 9 | 11 | - | - | - | 166 | D13 | 2 |
| 9 | 12 | 82 | B11 | 116 | 167 | A14 | 2 |
| 9 | 13 | - | - | 117 | 168 | E13 | 2 |
| 9 | 14 | - | A11 | 118 | 169 | A13 | 2 |
| 9 | 15 | - | - | 119 | 170 | C11 | 2 |
| 9 | 16 | - | C10 | - | 171 | A12 | 2 |
| 10 | 1 | 77 | A13 | 111 | 159 | A16 | 2 |
| 10 | 2 | 76 | B13 | 110 | 158 | B15 | 2 |
| 10 | 3 | 74 | C13 | 107 | 155 | C14 | 2 |
| 10 | 4 | 73 | C14 | 106 | 154 | G11 | 2 |
| 10 | 5 | 72 | D12 | 105 | 153 | B16 | 2 |
| 10 | 6 | 71 | D13 | 104 | 152 | D15 | 2 |
| 10 | 7 | - | - | - | - | - | - |
| 10 | 8 | - | - | - | - | - | - |
| 10 | 9 | - | - | - | - | - | - |
| 10 | 10 | - | - | - | - | - | - |
| 10 | 11 | | | | 151 | E14 | 2 |
| 10 | 12 | 70 | D14 | 103 | 150 | C16 | 2 |
| 10 | 13 | - | - | - | 149 | F14 | 2 |
| 10 | 14 | - | E12 | 102 | 148 | F13 | 2 |
| 10 | 15 | - | - | - | 147 | E15 | 2 |
| 10 | 16 | - | E13 | 101 | 146 | G13 | 2 |

Pin Descriptions (Continued)

| Function Block | Macro-cell | VQ100 | CP132 | TQ144 | PQ208 | FT256 | I/O Bank |
|----------------|------------|-------|-------|-------|-------|-------|----------|
| 11 | 1 | - | B10 | - | - | B11 | 2 |
| 11 | 2 | - | | - | 173 | D11 | 2 |
| 11 | 3 | - | A10 | - | 174 | A11 | 2 |
| 11 | 4 | - | - | - | 175 | D10 | 2 |
| 11 | 5 | - | C9 | 120 | - | B10 | 2 |
| 11 | 6 | - | - | 121 | - | E12 | 2 |
| 11 | 7 | - | - | - | - | - | - |
| 11 | 8 | - | - | - | - | - | - |
| 11 | 9 | - | - | - | - | - | - |
| 11 | 10 | - | - | - | - | - | - |
| 11 | 11 | 85 | A8 | 124 | 178 | F12 | 2 |
| 11 | 12 | 86 | B8 | 125 | 179 | B9 | 2 |
| 11 | 13 | 87 | C8 | 126 | 180 | C9 | 2 |
| 11 | 14 | 89 | - | 128 | 182 | C10 | 2 |
| 11 | 15 | - | - | 129 | 183 | A9 | 2 |
| 11 | 16 | - | - | 130 | 184 | D9 | 2 |
| 12 | 1 | - | - | - | 145 | F15 | 2 |
| 12 | 2 | - | - | 100 | 144 | G14 | 2 |
| 12 | 3 | - | - | - | 143 | E16 | 2 |
| 12 | 4 | - | - | - | 142 | H12 | 2 |
| 12 | 5 | - | F12 | - | 140 | F16 | 2 |
| 12 | 6 | - | F13 | - | 139 | H16 | 2 |
| 12 | 7 | - | - | - | - | - | - |
| 12 | 8 | - | - | - | - | - | - |
| 12 | 9 | - | - | - | - | - | - |
| 12 | 10 | - | - | - | - | - | - |
| 12 | 11 | 68 | F14 | 98 | 138 | G15 | 2 |
| 12 | 12 | - | G12 | 97 | 137 | H13 | 2 |
| 12 | 13 | 67 | G13 | 96 | 136 | G16 | 2 |
| 12 | 14 | 66 | - | 95 | 135 | H14 | 2 |
| 12 | 15 | 65 | - | 94 | 134 | H15 | 2 |
| 12 | 16 | - | - | - | - | J12 | 2 |

Pin Descriptions (Continued)

| Function Block | Macro-cell | VQ100 | CP132 | TQ144 | PQ208 | FT256 | I/O Bank |
|----------------|------------|-------|-------|-------|-------|-------|----------|
| 13 | 1 | - | N13 | 75 | 107 | R15 | 1 |
| 13 | 2 | 53 | N14 | 76 | 108 | T16 | 1 |
| 13 | 3 | - | M12 | 77 | 109 | N14 | 1 |
| 13 | 4 | 54 | - | - | 110 | R16 | 1 |
| 13 | 5 | - | M13 | 78 | 111 | N15 | 1 |
| 13 | 6 | 55 | - | 79 | 112 | M15 | 1 |
| 13 | 7 | - | - | - | - | - | - |
| 13 | 8 | - | - | - | - | - | - |
| 13 | 9 | - | - | - | - | - | - |
| 13 | 10 | - | - | - | - | - | - |
| 13 | 11 | - | - | - | - | - | - |
| 13 | 12 | - | M14 | 80 | 113 | M13 | 1 |
| 13 | 13 | 56 | - | 81 | 114 | P16 | 1 |
| 13 | 14 | - | L12 | 82 | 115 | N16 | 1 |
| 13 | 15 | - | - | - | 116 | L14 | 1 |
| 13 | 16 | - | L13 | - | 117 | M14 | 1 |
| 14 | 1 | 52 | P14 | 74 | 106 | P15 | 1 |
| 14 | 2 | - | - | 71 | 103 | P14 | 1 |
| 14 | 3 | 50 | P12 | 70 | 102 | P13 | 1 |
| 14 | 4 | - | M11 | 69 | 101 | R13 | 1 |
| 14 | 5 | 49 | N11 | - | 100 | N13 | 1 |
| 14 | 6 | - | P11 | 68 | - | R14 | 1 |
| 14 | 7 | - | - | - | - | - | - |
| 14 | 8 | - | - | - | - | - | - |
| 14 | 9 | - | - | - | - | - | - |
| 14 | 10 | - | - | - | - | - | - |
| 14 | 11 | - | - | - | - | - | - |
| 14 | 12 | - | - | - | 99 | T15 | 1 |
| 14 | 13 | - | - | 66 | 97 | R12 | 1 |
| 14 | 14 | 46 | P10 | 64 | 95 | N11 | 1 |
| 14 | 15 | 44 | - | - | - | M11 | 1 |
| 14 | 16 | - | P9 | 61 | 91 | N10 | 1 |

Pin Descriptions (Continued)

| Function Block | Macro-cell | VQ100 | CP132 | TQ144 | PQ208 | FT256 | I/O Bank |
|----------------|------------|-------|-------|-------|-------|-------|----------|
| 15 | 1 | - | - | - | 118 | L15 | 1 |
| 15 | 2 | - | L14 | 83 | 119 | L13 | 1 |
| 15 | 3 | - | - | - | 120 | M12 | 1 |
| 15 | 4 | - | - | - | 121 | M16 | 1 |
| 15 | 5 | - | - | - | 122 | K14 | 1 |
| 15 | 6 | - | - | - | 123 | L16 | 1 |
| 15 | 7 | - | - | - | - | - | - |
| 15 | 8 | - | - | - | - | - | - |
| 15 | 9 | - | - | - | - | - | - |
| 15 | 10 | - | - | - | - | - | - |
| 15 | 11 | 58 | K13 | 85 | 125 | K15 | 1 |
| 15 | 12 | 59 | K14 | 86 | 126 | L12 | 1 |
| 15 | 13 | 60 | J12 | 87 | 127 | K16 | 1 |
| 15 | 14 | 61 | J13 | 88 | 128 | J14 | 1 |
| 15 | 15 | 63 | H13 | 91 | - | J15 | 1 |
| 15 | 16 | 64 | H12 | 92 | 131 | J13 | 1 |
| 16 | 1 | - | - | - | 90 | P10 | 1 |
| 16 | 2 | - | - | - | 89 | R10 | 1 |
| 16 | 3 | - | M8 | - | 88 | T10 | 1 |
| 16 | 4 | - | - | - | 87 | R9 | 1 |
| 16 | 5 | 43 | N8 | 60 | 86 | N9 | 1 |
| 16 | 6 | 42 | - | 59 | 85 | M8 | 1 |
| 16 | 7 | - | - | - | - | - | - |
| 16 | 8 | - | - | - | - | - | - |
| 16 | 9 | - | - | - | - | - | - |
| 16 | 10 | - | - | - | - | - | - |
| 16 | 11 | 41 | P8 | 58 | 84 | T8 | 1 |
| 16 | 12 | 40 | M7 | 57 | 83 | P8 | 1 |
| 16 | 13 | 39 | N7 | 56 | 82 | R8 | 1 |
| 16 | 14 | - | - | - | 80 | T7 | 1 |
| 16 | 15 | - | - | 54 | 78 | N8 | 1 |
| 16 | 16 | - | P6 | 53 | 77 | T6 | 1 |

Notes:

1. GTS = global output enable, GSR = global reset/set, GCK = global clock, CDRST = clock divide reset, DGE = DataGATE enable.
2. GTS, GSR and GCK pins can be used for general purpose I/O.

XC2C256 JTAG, Power/Ground, No Connect Pins and Total User I/O

| Pin Type | VQ100 | CP132 | TQ144 | PQ208 | FT256 |
|--|---------------------------------|---|---|--|--|
| TCK | 48 | M10 | 67 | 98 | P12 |
| TDI | 45 | M9 | 63 | 94 | R11 |
| TDO | 83 | B9 | 122 | 176 | A10 |
| TMS | 47 | N10 | 65 | 96 | N12 |
| V _{CCAUX} (JTAG supply voltage) | 5 | D3 | 8 | 11 | F4 |
| Power internal (V _{CC}) | 26, 57 | P1, K12, A2 | 1, 37, 84 | 1, 53, 124 | P3, K13, D12, D5 |
| Power Bank 1 I/O (V _{CCIO1}) | 20, 38, 51 | J3, P7, G14, P13 | 27, 55, 73, 93 | 33, 59, 79, 92, 105, 132 | J6, K6, L7, L8, J11, K11, L10, L9 |
| Power Bank 2 I/O (V _{CCIO2}) | 88, 98 | A14, C4, A7 | 109, 127, 141 | 26, 133, 157, 172, 181, 204 | F7, F8, G6, H6, F10, F9, H11 |
| Ground | 21, 25, 31, 62, 69, 75, 84, 100 | K2, N1, P4, N9, N12, J14, H14, E14, B14, A9, B3 | 29, 36, 47, 62, 72, 89, 90, 99, 108, 123, 144 | 13, 24, 42, 52, 68, 81, 93, 104, 129, 130, 141, 156, 177, 190, 207 | F11, F6, G10, G7, G8, G9, H10, H7, H8, H9, J10, J7, J8, J9, K10, K7, K8, K9, L11, L6 |
| No connects | - | - | - | - | A1, C2, E6, D1, E1, G2, F1, G1, M4, T9, P9, M9, M10, T11, T12, T13, P11, T14, J16, K12, D16, G12, C15, D14, D6, C6, E7, C5 |
| Total user I/O | 80 | 106 | 118 | 173 | 184 |

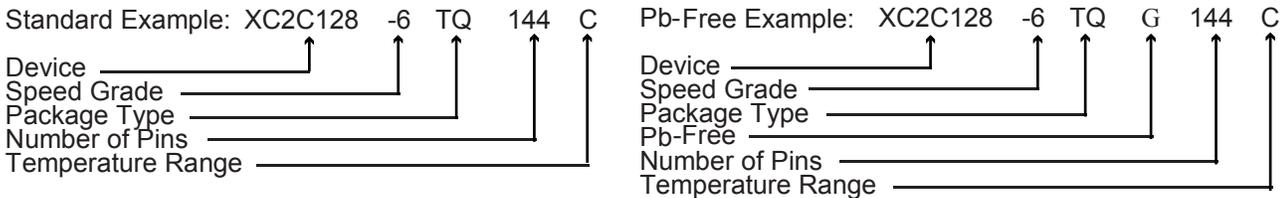
Ordering Information

| Part Number | Pin/Ball Spacing | θ_{JA} (C/Watt) | θ_{JC} (C/Watt) | Package Type | Package Body Dimensions | I/O | Commercial (C) Industrial (I) ⁽¹⁾ |
|------------------|------------------|---------------------------|---------------------------|-----------------------------------|-------------------------|-----|---|
| XC2C256-6VQ100C | 0.5mm | 43.1 | 10.9 | Very Thin Quad Flat Pack | 14mm x 14mm | 80 | C |
| XC2C256-7VQ100C | 0.5mm | 43.1 | 10.9 | Very Thin Quad Flat Pack | 14mm x 14mm | 80 | C |
| XC2C256-6CP132C | 0.5mm | 65.0 | 15.0 | Chip Scale Package | 8mm x 8mm | 106 | C |
| XC2C256-7CP132C | 0.5mm | 65.0 | 15.0 | Chip Scale Package | 8mm x 8mm | 106 | C |
| XC2C256-6TQ144C | 0.5mm | 37.2 | 7.2 | Thin Quad Flat Pack | 20mm x 20mm | 118 | C |
| XC2C256-7TQ144C | 0.5mm | 37.2 | 7.2 | Thin Quad Flat Pack | 20mm x 20mm | 118 | C |
| XC2C256-6PQ208C | 0.5mm | 36.9 | 9.7 | Plastic Quad Flat Pack | 28mm x 28mm | 173 | C |
| XC2C256-7PQ208C | 0.5mm | 36.9 | 9.7 | Plastic Quad Flat Pack | 28mm x 28mm | 173 | C |
| XC2C256-6FT256C | 1.0mm | 34.6 | 6.1 | Fine Pitch Thin BGA | 17mm x 17mm | 184 | C |
| XC2C256-7FT256C | 1.0mm | 34.6 | 6.1 | Fine Pitch Thin BGA | 17mm x 17mm | 184 | C |
| XC2C256-6VQG100C | 0.5mm | 43.1 | 10.9 | Very Thin Quad Flat Pack; Pb-free | 14mm x 14mm | 80 | C |
| XC2C256-7VQG100C | 0.5mm | 43.1 | 10.9 | Very Thin Quad Flat Pack; Pb-free | 14mm x 14mm | 80 | C |
| XC2C256-6CPG132C | 0.5mm | 65.0 | 15.0 | Chip Scale Package; Pb-free | 8mm x 8mm | 106 | C |
| XC2C256-7CPG132C | 0.5mm | 65.0 | 15.0 | Chip Scale Package; Pb-free | 8mm x 8mm | 106 | C |
| XC2C256-6TQG144C | 0.5mm | 37.2 | 7.2 | Thin Quad Flat Pack; Pb-free | 20mm x 20mm | 118 | C |
| XC2C256-7TQG144C | 0.5mm | 37.2 | 7.2 | Thin Quad Flat Pack; Pb-free | 20mm x 20mm | 118 | C |
| XC2C256-6PQG208C | 0.5mm | 36.9 | 9.7 | Plastic Quad Flat Pack; Pb-free | 28mm x 28mm | 173 | C |
| XC2C256-7PQG208C | 0.5mm | 36.9 | 9.7 | Plastic Quad Flat Pack; Pb-free | 28mm x 28mm | 173 | C |
| XC2C256-6FTG256C | 1.0mm | 34.6 | 6.1 | Fine Pitch Thin BGA; Pb-free | 17mm x 17mm | 184 | C |
| XC2C256-7FTG256C | 1.0mm | 34.6 | 6.1 | Fine Pitch Thin BGA; Pb-free | 17mm x 17mm | 184 | C |
| XC2C256-7VQ100I | 0.5mm | 43.1 | 10.9 | Very Thin Quad Flat Pack | 14mm x 14mm | 80 | I |
| XC2C256-7CP132I | 0.5mm | 65.0 | 15.0 | Chip Scale Package | 8mm x 8mm | 106 | I |
| XC2C256-7TQ144I | 0.5mm | 37.2 | 7.2 | Thin Quad Flat Pack | 20mm x 20mm | 118 | I |
| XC2C256-7PQ208I | 0.5mm | 36.9 | 9.7 | Plastic Quad Flat Pack | 28mm x 28mm | 173 | I |
| XC2C256-7FT256I | 1.0mm | 34.6 | 6.1 | Fine Pitch Thin BGA | 17mm x 17mm | 184 | I |

| Part Number | Pin/Ball Spacing | θ_{JA} (C/Watt) | θ_{JC} (C/Watt) | Package Type | Package Body Dimensions | I/O | Commercial (C) Industrial (I) ⁽¹⁾ |
|------------------|------------------|------------------------|------------------------|-----------------------------------|-------------------------|-----|--|
| XC2C256-7VQG100I | 0.5mm | 43.1 | 10.9 | Very Thin Quad Flat Pack; Pb-free | 14mm x 14mm | 80 | I |
| XC2C256-7CPG132I | 0.5mm | 65.0 | 15.0 | Chip Scale Package; Pb-free | 8mm x 8mm | 106 | I |
| XC2C256-7TQG144I | 0.5mm | 37.2 | 7.2 | Thin Quad Flat Pack; Pb-free | 20mm x 20mm | 118 | I |
| XC2C256-7PQG208I | 0.5mm | 36.9 | 9.7 | Plastic Quad Flat Pack; Pb-free | 28mm x 28mm | 173 | I |
| XC2C256-7FTG256I | 1.0mm | 34.6 | 6.1 | Fine Pitch Thin BGA; Pb-free | 17mm x 17mm | 184 | I |

Notes:

1. C = Commercial ($T_A = 0^\circ\text{C}$ to $+70^\circ\text{C}$); I = Industrial ($T_A = -40^\circ\text{C}$ to $+85^\circ\text{C}$).



Device Part Marking

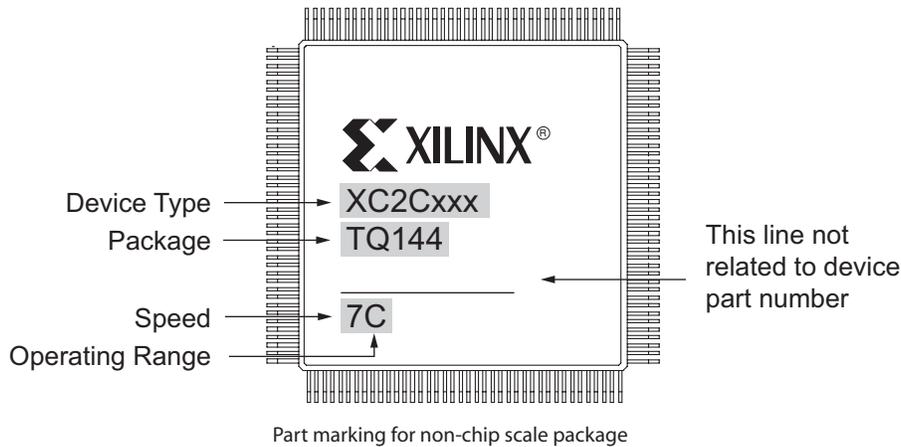
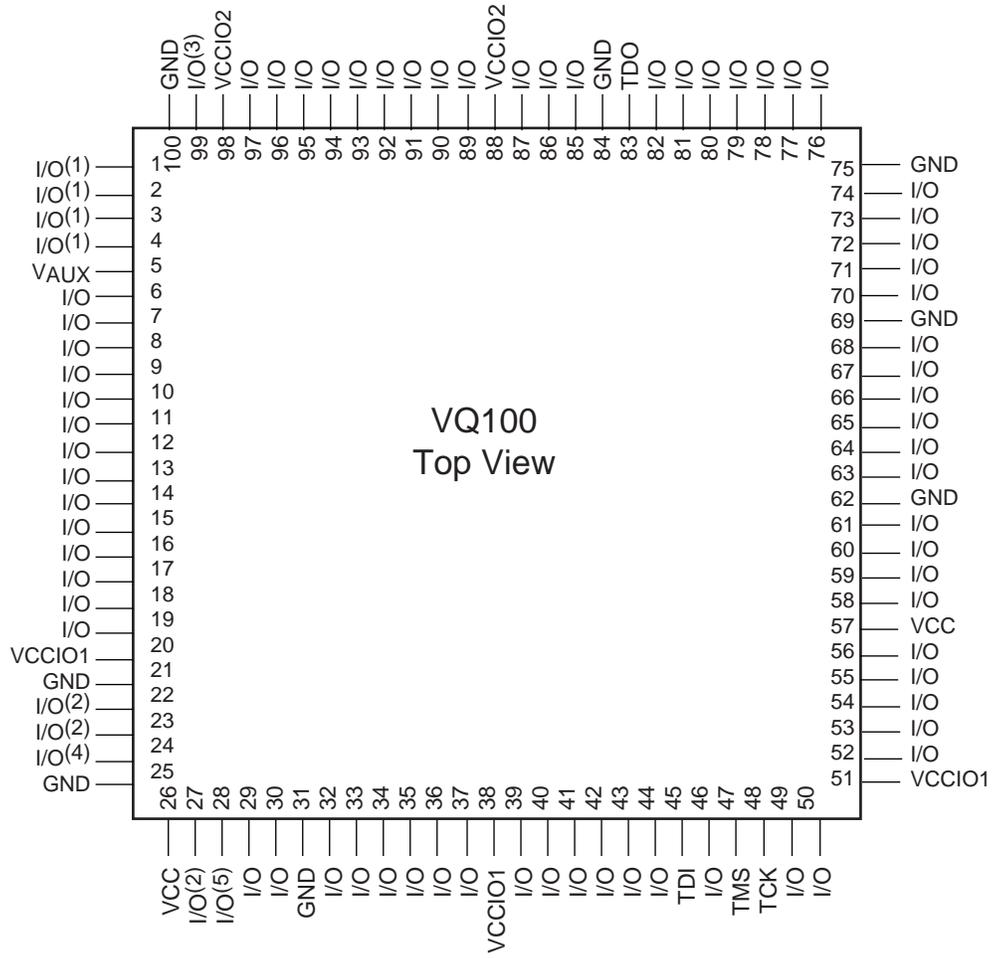


Figure 5: Sample Package with Part Marking

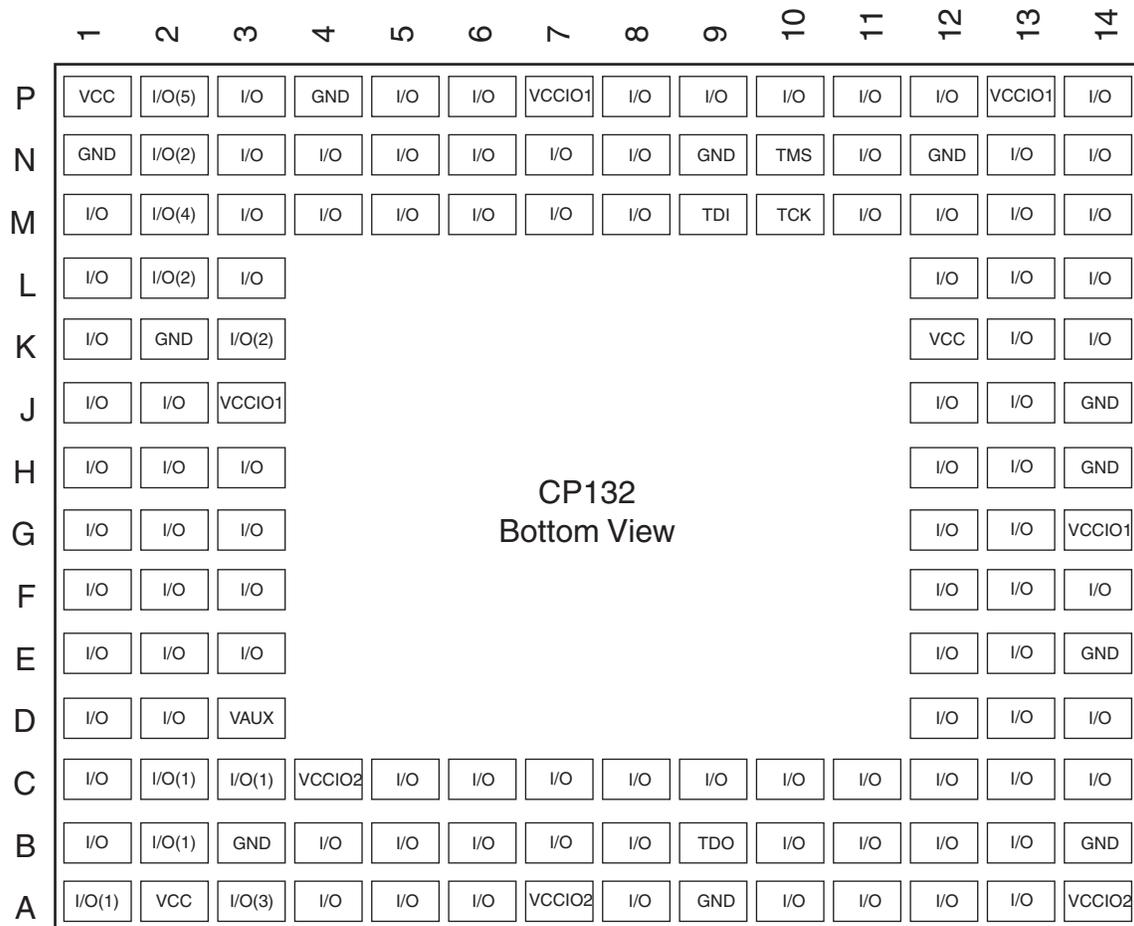
Note: Due to the small size of chip scale packages, the complete ordering part number cannot be included on the package marking. Part marking on chip scale packages by line are:

- Line 1 = X (Xilinx logo) then truncated part number
- Line 2 = Not related to device part number
- Line 3 = Not related to device part number
- 1. Line 4 = Package code, speed, operating temperature, three digits not related to device part number. Package codes: C5 = CP132, C6 = CPG132.



- (1) - Global Output Enable
- (2) - Global Clock
- (3) - Global Set/Reset
- (4) - Clock Divide Reset
- (5) - Data Gate

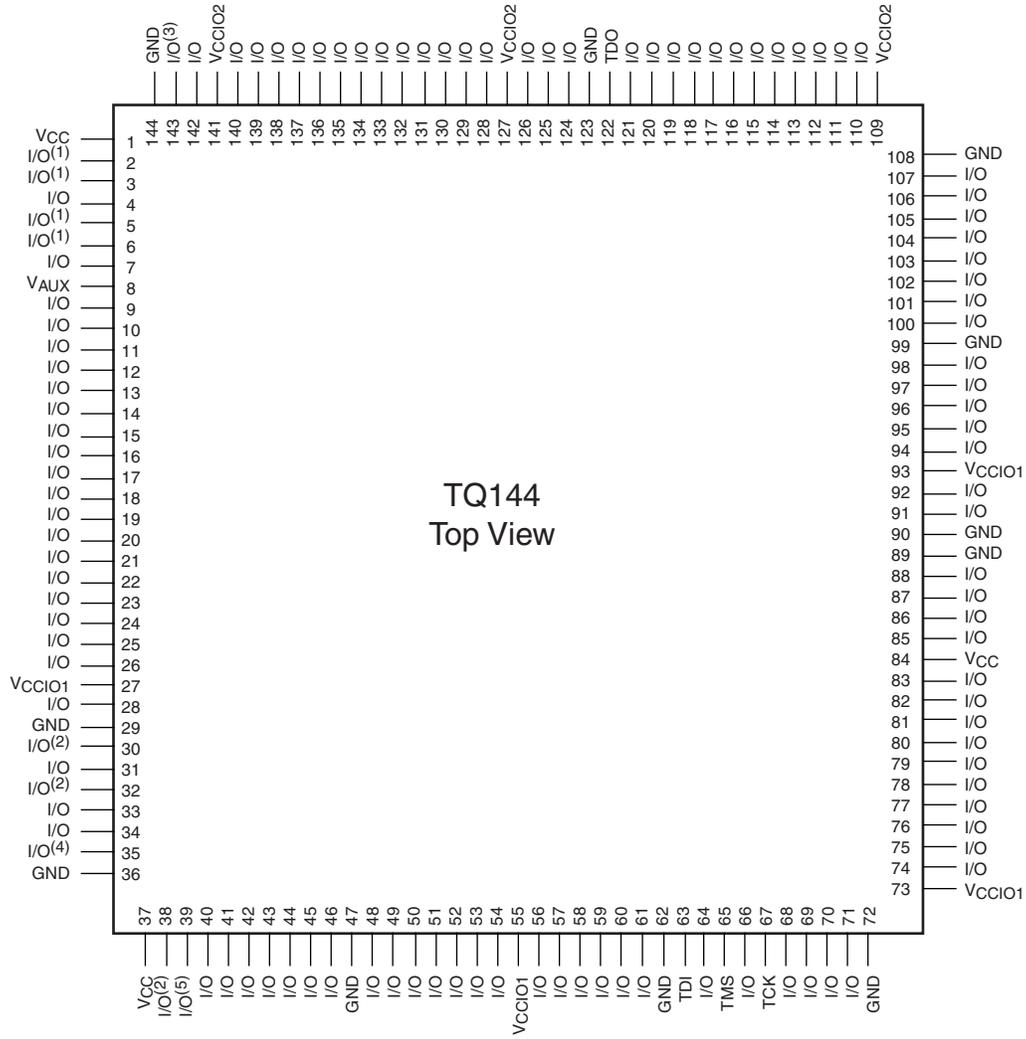
Figure 6: VQ100 Very Thin Quad Flat Pack



CP132
Bottom View

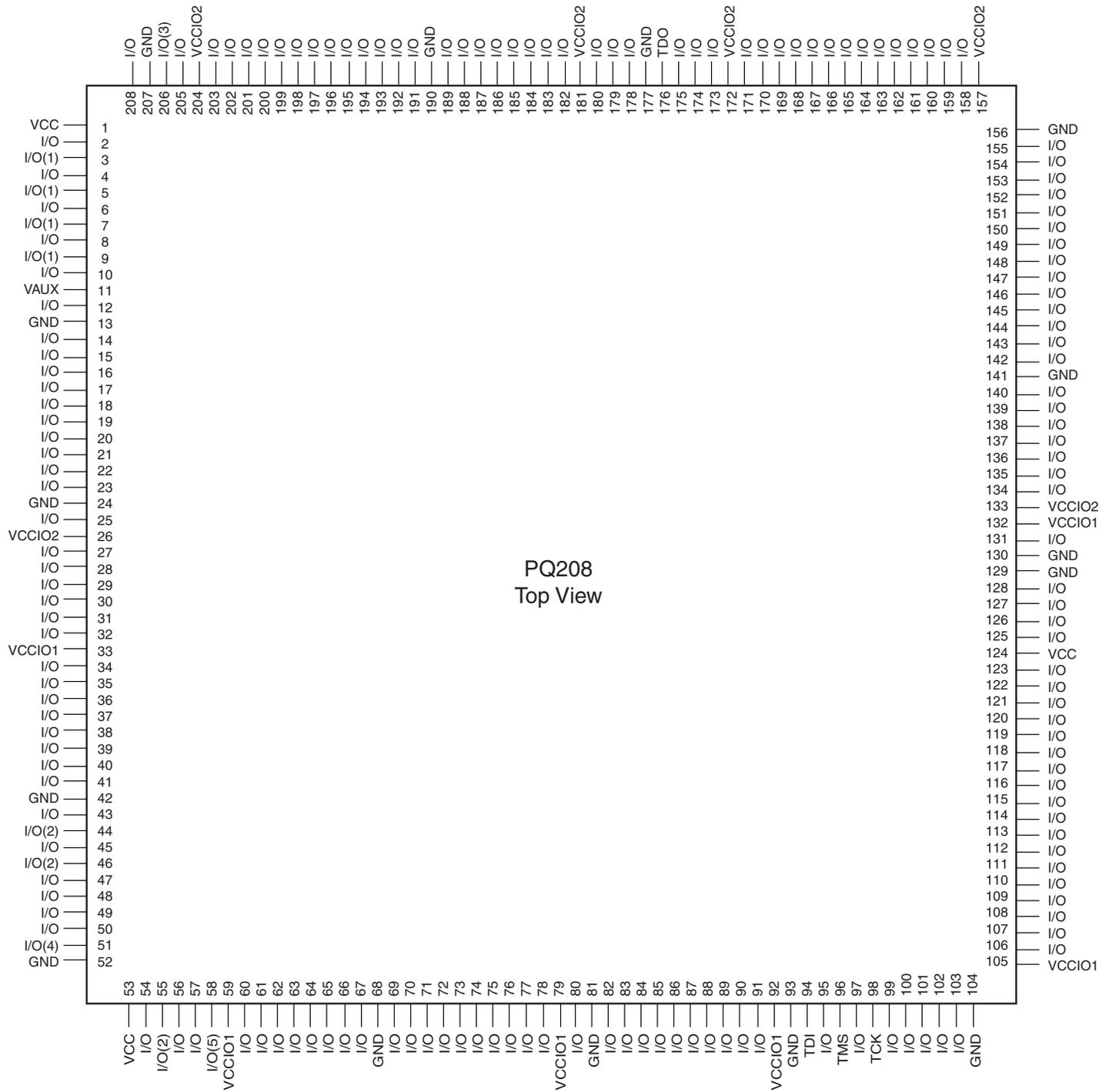
- (1) - Global Output Enable
- (2) - Global Clock
- (3) - Global Set/Reset
- (4) - Clock Divide Reset
- (5) - DataGATE Enable

Figure 7: CP132 Chip Scale Package



- (1) - Global Output Enable
- (2) - Global Clock
- (3) - Global Set/Reset
- (4) - Clock Divide Reset
- (5) - DataGATE Enable

Figure 8: TQ144 Thin Quad Flat Pack



- (1) - Global Output Enable
- (2) - Global Clock
- (3) - Global Set/Reset
- (4) - Clock Divide Reset
- (5) - DataGATE Enable

Figure 9: PQ208 Quad Flat Package

| | 16 | 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 |
|---|-----|-----|-----|-----|-----|--------|--------|--------|--------|--------|--------|--------|--------|--------|--------|-----|
| A | I/O | I/O | I/O | I/O | I/O | I/O | TDO | I/O | NC |
| B | I/O | I/O | I/O | I/O | I/O | I/O | I/O | I/O | I/O | I/O | I/O | I/O | I/O | I/O | I/O | I/O |
| C | I/O | NC | I/O | I/O | I/O | I/O | I/O | I/O | I/O | I/O | NC | NC | I/O(3) | I/O | NC | I/O |
| D | NC | I/O | NC | I/O | VCC | I/O | I/O | I/O | I/O | I/O | NC | VCC | I/O(1) | I/O(1) | I/O | NC |
| E | I/O | I/O | I/O | I/O | I/O | I/O | I/O | I/O | I/O | NC | NC | I/O(1) | I/O | I/O(1) | I/O | NC |
| F | I/O | I/O | I/O | I/O | I/O | GND | VCCIO2 | VCCIO2 | VCCIO2 | VCCIO2 | GND | I/O | VAUX | I/O | I/O | NC |
| G | I/O | I/O | I/O | I/O | NC | I/O | GND | GND | GND | GND | VCCIO2 | I/O | I/O | I/O | NC | NC |
| H | I/O | I/O | I/O | I/O | I/O | VCCIO2 | GND | GND | GND | GND | VCCIO2 | I/O | I/O | I/O | I/O | I/O |
| J | NC | I/O | I/O | I/O | I/O | VCCIO1 | GND | GND | GND | GND | VCCIO1 | I/O | I/O | I/O | I/O | I/O |
| K | I/O | I/O | I/O | VCC | NC | VCCIO1 | GND | GND | GND | GND | VCCIO1 | I/O | I/O | I/O | I/O | I/O |
| L | I/O | I/O | I/O | I/O | I/O | GND | VCCIO1 | VCCIO1 | VCCIO1 | VCCIO1 | GND | I/O | I/O | I/O | I/O | I/O |
| M | I/O | I/O | I/O | I/O | I/O | I/O | NC | NC | I/O | I/O | I/O | I/O | NC | I/O(2) | I/O(2) | I/O |
| N | I/O | I/O | I/O | I/O | TMS | I/O | I/O |
| P | I/O | I/O | I/O | I/O | TCK | NC | I/O | NC | I/O | I/O | I/O | I/O(2) | I/O | VCC | I/O(4) | I/O |
| R | I/O | I/O | I/O | I/O | I/O | TDI | I/O | I/O |
| T | I/O | I/O | NC | NC | NC | NC | I/O | NC | I/O | I/O | I/O | I/O | I/O | I/O | I/O(5) | I/O |

FT256 Bottom View

- (1) - Global Output Enable
- (2) - Global Clock
- (3) - Global Set/Reset
- (4) - Clock Divide Reset
- (5) - DataGATE Enable

Figure 10: FT256 Fine Pitch Thin BGA

Warranty Disclaimer

THESE PRODUCTS ARE SUBJECT TO THE TERMS OF THE XILINX LIMITED WARRANTY WHICH CAN BE VIEWED AT <http://www.xilinx.com/warranty.htm>. THIS LIMITED WARRANTY DOES NOT EXTEND TO ANY USE OF THE PRODUCTS IN AN APPLICATION OR ENVIRONMENT THAT IS NOT WITHIN THE SPECIFICATIONS STATED ON THE THEN-CURRENT XILINX DATA SHEET FOR THE PRODUCTS. PRODUCTS ARE NOT DESIGNED TO BE FAIL-SAFE AND ARE NOT WARRANTED FOR USE IN APPLICATIONS THAT POSE A RISK OF PHYSICAL HARM OR LOSS OF LIFE. USE OF PRODUCTS IN SUCH APPLICATIONS IS FULLY AT THE RISK OF CUSTOMER SUBJECT TO APPLICABLE LAWS AND REGULATIONS.

Additional Information

Additional information is available for the following CoolRunner-II topics:

- XAPP784: Bulletproof CPLD Design Practices
- XAPP375: Timing Model
- XAPP376: Logic Engine
- XAPP378: Advanced Features
- XAPP382: I/O Characteristics
- XAPP389: Powering CoolRunner-II
- XAPP399: Assigning VREF Pins

To access these and all application notes with their associated reference designs, click the following link and scroll down the page until you find the document you want:

[CoolRunner-II Data Sheets and Application Notes Device Packages](#)

Revision History

The following table shows the revision history for this document.

| Date | Version | Revision |
|----------|---------|--|
| 05/09/02 | 1.0 | Initial Xilinx release. |
| 05/13/02 | 1.1 | Updated AC Electrical Characteristics and added new parameters. |
| 10/31/02 | 1.2 | Corrected package user I/O, added Voltage Referenced DC tables. |
| 03/17/03 | 2.0 | Added Characterization numbers for product release and device part marking |
| 04/02/03 | 2.1 | Updated T_{SOL} max from 260 to 220. Changed I_{CCSB} units from mA to μ A. |
| 01/26/04 | 2.2 | Updated Device Part Marking. Updated links and Tsol. |
| 02/26/04 | 2.3 | Corrected Theta JC value on XC2C256-7TQ144. |
| 08/03/04 | 2.4 | Pb-free documentation |
| 08/19/04 | 2.5 | Changes to I_{CCSB} maximum specifications in DC Electrical Characteristics table, on page 3. |
| 10/01/04 | 2.6 | Add Asynchronous Preset/Reset Pulse Width specification to AC Electrical Characteristics. |
| 03/07/05 | 2.7 | Removed -5 speed grade. Changes to Table 1, I/O Standards. |
| 06/28/05 | 2.8 | Move to Product Specification. Change to T_{IN25} , T_{OUT25} , T_{IN33} , and T_{OUT33} for -7 speed grade. |
| 03/20/06 | 2.9 | Add Warranty Disclaimer. Add note to Pin Description table that GTS, GSR and GCK pins can be used for general purpose I/O. |
| 5/20/06 | 3.0 | Moved T_{CONFIG} specification values from MIN column to MAX column, page 7. |
| 02/15/07 | 3.1 | Corrections to timing parameters t_{AOI} , t_{PSUD} , t_{PSU1} , t_{PSU2} , t_{PHD} , t_{PCO} , t_{POE} , t_{PAO} , t_{AO} , t_{SUEC} , t_{CW} , t_{CDRSU} , and f_{TOGGLE} for -6 speed grade. Corrections to t_{PSUD} , t_{CW} , and t_{CDRSU} for the -7 speed grade. Values now match the software. There were no changes to silicon or characterization. Change to V_{IH} specification for 2.5V and 1.8V LVCMOS. |
| 03/08/07 | 3.2 | Fixed typo in note for V_{IL} for LVCMOS18; removed note for V_{IL} for LVCMOS33. |